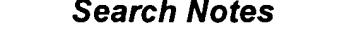


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/617,055	LEE ET AL.
	Examiner	Art Unit
	Emeka Ebirim	2166

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST search	7/20/2006	EE
Consulted Pham Khanh (primary)	7/20/2006	EE
Google Scholar	7/20/2006	EE

INTERFERENCE SEARCHED			
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